## **Consideration of Feedback Mechanism in Depolarizing Field in Dielectric Material and Piezoelectric Transducer**

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## 1. Introduction

The depolarizing field strongly affects the characteristics of dielectric and piezoelectric materials and devices.

The permittivity  $\varepsilon$  of a dielectric material should be measured in the environment in which the depolarization coefficient is maximal. In this study, firstly, a feedback system to estimate the permittivity is considered, and by comparing a similar feedback system to estimate the permeability  $\mu$  of a magnetic material, it is clarified that appropriate estimates of  $\varepsilon$  and  $\mu$  can be obtained when no feedback is provided and that what is called *E-B* correspondence is more essential than *E-H* one.

In a piezoelectric transducer, the depolarizing field causes another effect on the characteristics of mechanical wave, and the behavior of the transducer is classified into two different types: that with longitudinal (L-) effect and that with transverse (T-) effect. In this study, another type of 'feedback effect' of depolarizing field is considered, which gives a more reasonable explanation for the characteristics of piezoelectric transducer.

## 2. Feedback system for measurement of permittivity and permeability



Fig. 1: Feedback diagram for measuring  $1/\varepsilon$ . N (0 < N < 1) is an (averaged) depolarizing coefficient, which affects the measurement via the feedback of depolarizing field from the output (electric field) to the input (dielectric flux density).  $N \rightarrow 0$  for an infinitely long rod, and  $N \rightarrow 1$  for an infinitely thin plate.

Figure 1 shows the effect of feedback of depolarizing field on measuring  $1/\varepsilon$ , where  $E_0$  is an input electric field, N (0 < N < 1) is an (averaged) depolarizing coefficient, P is a generated polarization, and a dielectric flux density D is related with a total electric field E as  $D = \varepsilon E = \varepsilon_0 E + P$ . A portion of the output is fed back into the input as (1 - N)P.

From the closed-loop characteristic, in which the output  $\boldsymbol{E}\left(=\frac{\boldsymbol{D}-\boldsymbol{P}}{\varepsilon_0}\right) = \boldsymbol{E}_0 - N\frac{\boldsymbol{P}}{\varepsilon_0}$  and the input  $\boldsymbol{D} = \varepsilon_0 \boldsymbol{E}_0 + (1-N)\boldsymbol{P}$ , an estimated value of  $1/\varepsilon$  is obtained as a function of N:

$$\frac{1}{\varepsilon}(N) = \frac{E_0 - N\frac{P}{\varepsilon_0}}{\varepsilon_0(E_0 + (1 - N)\frac{P}{\varepsilon_0})},\tag{1}$$

which provides a correct value of  $1/\varepsilon$  when  $N \to 1$ ; that is, when no output is fed back into the input.

For comparison, the effect of demagnetizing field on the measurement of a permeability  $\mu$  is schematized in Fig. 2, where  $H_0$  is an input magnetic field strength, N (0 < N < 1) is an averaged demagnetizing coefficient,  $\boldsymbol{M}$  is a generated magnetization, and a magnetic field  $\boldsymbol{B}$  is related with a total magnetic field strength  $\boldsymbol{H}$  as  $\boldsymbol{B} = \mu \boldsymbol{H} = \mu_0 (\boldsymbol{H} + \boldsymbol{M})$ , where  $\boldsymbol{H} = H_0 - N\boldsymbol{M}$  due to the feedback of  $\boldsymbol{M}$  by  $-N\boldsymbol{M}$ . From Fig. 2,  $\mu$  is estimated as

$$\mu(N) = \frac{\mu_0(H_0 + (1 - N)M)}{H_0 - NM},$$
(2)

in which a correct estimate of  $\mu$  can be obtained when  $N \rightarrow 0$  without any feedback effect.



Fig. 2: Feedback diagram to estimate  $\mu$ .

The comparison of the above feedback systems endorses the correspondence of  $E \leftrightarrow B$ , rather than that of  $E \leftrightarrow H$ , which has often been discussed in the interpretation of electromagnetic theory.

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3. Influence of depolarization field on piezoelectric transducers



Fig. 3: Equivalent circuit of a piezoelectric transducer at  $\omega \rightarrow 0$ .  $\alpha = 1$  for L-effect and  $\alpha = 0$  for T-effect.

Figure 3 shows the equivalent circuit of a piezoelectric transducer at low frequency limit,  $\omega \rightarrow 0$ , in which  $C_0$  and C are the dielectric capacitance and the 'intrinsic' elastic equivalent capacitance, respectively. The electromechanical coupling coefficient,  $k^2 = C'/(C_0 + C') = (1/C_0)/(1/C_0 + 1/C')$ , is calculated as

$$k^{2} = \frac{C}{C_{0} + (1 - \alpha)C} \qquad (0 \le k^{2} < 1), \qquad (3)$$

where  $\alpha = 1$  for L-effect, and  $\alpha = 0$  for T-effect.

The characteristics of piezoelectric transducers can schematically be classified into four patterns by considering whether L- or T-effect works and whether the E-terminal in Fig. 3 is opened or shorted, as shown in Fig. 4.



Fig. 4: Schematic diagram of the relationship among the surface charges on electrodes, polarization P, and wavenumber vector  $\mathbf{k}$ . (a), (a') L-effect ( $P \parallel \mathbf{k}$ ) for opened and shorted states, respectively. (b), (b') T-effect ( $P \perp \mathbf{k}$ ) for shorted and opened states, respectively.

In the L-effect ( $\boldsymbol{P} \parallel \boldsymbol{k}$ ), the opened state is regarded as the intrinsic state, as shown in Fig. 4(a), due to the continuity of  $\boldsymbol{D}$  normal to  $\boldsymbol{k}$ -planes that are perpendicular to  $\boldsymbol{k}$ . In the shorted state, Coulomb's force from the residual charges on the electrodes elongates the wavelength of polarization wave  $\lambda$ , and the elasticity is softened, as shown in Fig. 4(a'), which is represented by  $-C_0$  ( $\alpha = 1$ ) in Fig. 3.

In the T-effect  $(\mathbf{P} \perp \mathbf{k})$ , the shorted state is regarded as the intrinsic state, as shown in Fig. 4(b), due to the continuity of  $\mathbf{E}$  tangential to  $\mathbf{k}$ -planes. In the opened state, Coulomb's force from the surplus charges on the electrodes condenses  $\mathbf{P}$  and the elasticity is stiffened, while  $\lambda$  is invariant, as shown in Fig. 4(b'), which is represented by a series connection of  $C_0$  in Fig. 3.



Fig. 5: Primary Coulomb interaction between the surface charges and *P*, and secondary Coulomb interaction inside *P* as a negative feedback process.

As P becomes larger, a negative feedback process is expected to occur, as shown in Fig. 5, moderating the decrease of elastic stiffness, especially in the case of a high- $k^2$  material. This process is represented by (I) the depression of the effect of negative capacitance  $-C_0$  in the L-effect and (II) the addition of another positive capacitance in series in the T-effect, represented in common as

$$\alpha \to \alpha + \Delta \alpha \qquad (\Delta \alpha < 0) \tag{4}$$

In the L-effect ( $\alpha = 1$ ), unnaturally, the wavelength  $\lambda \to \infty$  as  $C \to C_0$  at the electrical resonance (shorted state), and  $k^2 > 1$  in eq. (3) if  $C > C_0$ . Nature is selfconsistent, and the above negative feedback effect keeps the value of  $\lambda$  and  $k^2$  appropriately. (In addition, while the total elastic capacitance is depressed by the effect of  $\Delta \alpha (< 0)$ , the inertial inductance is expected to be enhanced by way of compensation.)